ESD5B5.0S, SZESD5B5.0S

ESD Protection Diode

Micro-Packaged Diodes for ESD Protection

The ESD5B Series is designed to protect voltage sensitive components from ESD. Excellent clamping capability, low leakage, and fast response time provide best in class protection on designs that are exposed to ESD. Because of its small size and bi-directional design, it is ideal for use in cellular phones, MP3 players, and portable



ON Semiconductor®

www.onsemi.com

applications that require audio line protectiesD5B系列旨在保护电压敏感组件免受ESD影响。出色的钳位能力,低泄漏和快 速响应时间为暴露于ESD的设计提供了一流的保护。由于其外积小和双向设计,

最终产品

好处

Specification Features

• Low Capacitance 32 pF

• Low Clamping Voltage

• Small Body Outline Dimensions: nom 0.063" x 0.032" (1.6x0.8 mm)
• Low Body Height: nom 0.024" (0.6 mm)
上限= 32 pf

• Low Body Height: nom 0.024" (0.6 mm)

● Reverse Working (Stand-off) Voltage: → 保留高速数据线的信号完整性

• Peak Power up to 50 W @ 8 x 20 μs Puls低泄漏

• Low Leakage

延长电池寿命 • Response Time is Typically < 1 ns

• ESD Rating of Class 3 (> 16 kV) per Human Body Model V触点

• IEC61000-4-2 Level 4 ESD Protection 在最严酷的ESD条件下提供--流的保护

特征

• SZ Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable

长寿

应用领域

扬声器线

保护敏感组件

• This is a Pb-Free Device

Mechanical Characteristics

Epoxy Meets UL 94 V-0

LEAD FINISH: 100% Matte Sn (Tin)

MOUNTING POSITION: Any

Device Meets MSL 1 Requirements

因此非常适合用于蜂窝电话,MP3播放器以及需要音频线路保护的便携式应用。

SOD-523 **CASE 502**

MARKING DIAGRAM



= Specific Device Code

Date Code

= Pb-Free Package 和宗表系统数能 in either location)

*Date Code orientation and/or position may vary depending upon manufacturing location.

MAXIMUM RATINGS

Rating	Symbol	Value	Unit	
IEC 61000-4-2 (ESD)	Contact Air		±30 ±30	kV
ESD Voltage Per Human Body Model Per Machine Model			16 400	kV V
Peak Power (Figure 1) Per 8 x 20 μs Waveform Peak Power (Figure 2)Per 10 x 1000 μs Waveform		P _{PK}	50 10	V
Total Power Dissipation on FR-5 Board @ T _A = 25°C	P_{D}	200	mW	
Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150	°C
Lead Solder Temperature – Maximum (10 Second Duration)		T_L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. $FR-5 = 1.0 \times 0.75 \times 0.62$ in.

See Application Note AND8308/D for further description of survivability specs.

ORDERING INFORMATION

Device	Package	Shipping [†]
ESD5B5.0ST1G	SOD-523 (Pb-Free)	3000 / Tape & Reel
ESD5B5.0ST5G	SOD-523 (Pb-Free)	8000 / Tape & Reel
SZESD5B5.0ST1G	SOD-523 (Pb-Free)	3000 / Tape & Reel
SZESD5B5.0ST5G	SOD-523 (Pb-Free)	8000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

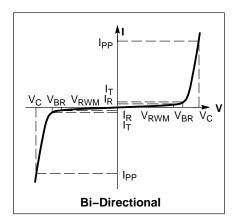
ESD5B5.0S, **SZESD5B5.0S**

ELECTRICAL CHARACTERISTICS

 $(T_A = 25^{\circ}C \text{ unless otherwise noted})$

Symbol	Parameter		
I _{PP}	Reverse Peak Pulse Current		
V _C	Clamping Voltage @ IPP		
V_{RWM}	Working Peak Reverse Voltage		
I _R	Reverse Leakage Current @ V _{RWM}		
V_{BR}	Breakdown Voltage @ I _T		
I _T	Test Current		

^{*}See Application Note AND8308/D for detailed explanations of datasheet parameters.



ELECTRICAL CHARACTERISTICS ($T_A = 25^{\circ}C$ unless otherwise noted, $V_F = 0.9 \text{ V}$ Max. @ $I_F = 10 \text{ mA}$ for all types)

	V _{RWM} (V)	I _R (μΑ) @ V _{RWM}	V _{BR} (V (Not		Ι _Τ	C (pF) @ V _R = 0 V, f = 1 MHz	V _C
Device*	Max	Max	Min	Max	mA	Тур	Per IEC61000-4-2 (Note 3)
ESD5B5.0ST1G/T5G, SZESD5B5.0ST1G	5.0	1.0	5.8	7.8	1.0	32	Figures 1 and 2 See Below

^{*}Other voltages available upon request.

- 2. V_{BR} is measured with a pulse test current I_T at an ambient temperature of 25°C.
- 3. For test procedure see Figures 3 and 4 and Application Note AND8307/D.

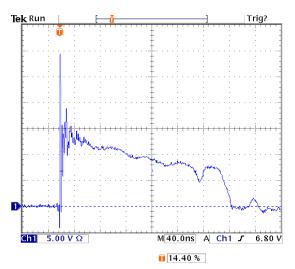


Figure 1. ESD Clamping Voltage Screenshot Positive 8 kV Contact per IEC 61000-4-2

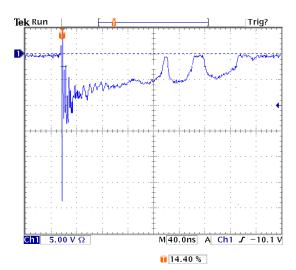


Figure 2. ESD Clamping Voltage Screenshot Negative 8 kV Contact per IEC 61000-4-2

ESD5B5.0S, SZESD5B5.0S

IEC 61000-4-2 Spec.

	-			
Level	Test Volt- age (kV)	First Peak Current (A)	Current at 30 ns (A)	Current at 60 ns (A)
1	2	7.5	4	2
2	4	15	8	4
3	6	22.5	12	6
4	8	30	16	8

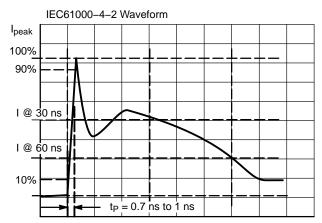


Figure 3. IEC61000-4-2 Spec

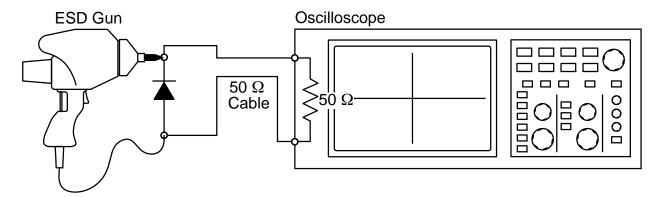


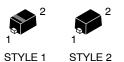
Figure 4. Diagram of ESD Test Setup

The following is taken from Application Note AND8308/D – Interpretation of Datasheet Parameters for ESD Devices.

ESD Voltage Clamping

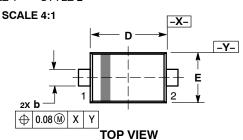
For sensitive circuit elements it is important to limit the voltage that an IC will be exposed to during an ESD event to as low a voltage as possible. The ESD clamping voltage is the voltage drop across the ESD protection diode during an ESD event per the IEC61000–4–2 waveform. Since the IEC61000–4–2 was written as a pass/fail spec for larger

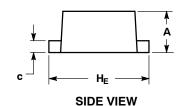
systems such as cell phones or laptop computers it is not clearly defined in the spec how to specify a clamping voltage at the device level. ON Semiconductor has developed a way to examine the entire voltage waveform across the ESD protection diode over the time domain of an ESD pulse in the form of an oscilloscope screenshot, which can be found on the datasheets for all ESD protection diodes. For more information on how ON Semiconductor creates these screenshots and how to interpret them please refer to AND8307/D.

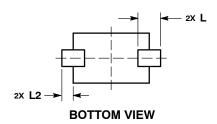


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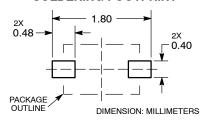
DATE 28 SEP 2010







RECOMMENDED SOLDERING FOOTPRINT*



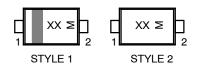
*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
 MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PRO-TRUSIONS, OR GATE BURRS.

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.50	0.60	0.70		
b	0.25	0.30	0.35		
С	0.07	0.14	0.20		
D	1.10	1.20	1.30		
E	0.70	0.80	0.90		
HE	1.50	1.60	1.70		
L	0.30 REF				
L2	0.15	0.20	0.25		

GENERIC MARKING DIAGRAM*



XX = Specific Device Code Date Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

STYLE 1: PIN 1. CATHODE (POLARITY BAND) STYLE 2: NO POLARITY 2. ANODE

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